

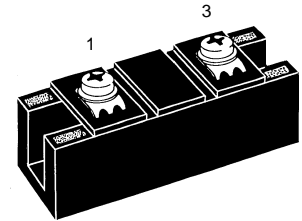
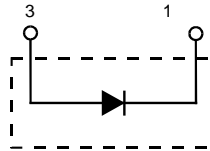
Fast Recovery Epitaxial Diode (FRED) Module

MEO 450-12 DA

$V_{RRM} = 1200\text{ V}$
 $I_{FAVM} = 453\text{ A}$
 $t_{rr} = 450\text{ ns}$

Preliminary data

V_{RSM}	V_{RRM}	Type
V	V	
1200	1200	MEO 450-12DA



Symbol	Test Conditions	Maximum Ratings
I_{FRMS}	$T_C = 75^\circ\text{C}$	640 A
I_{FAVM} ①	$T_C = 75^\circ\text{C}$; rectangular, $d = 0.5$	453 A
I_{FRM}	$t_p < 10\ \mu\text{s}$; rep. rating, pulse width limited by T_{VJM}	2460 A
I_{FSM}	$T_{VJ} = 45^\circ\text{C}$; $t = 10\text{ ms}$ (50 Hz), sine $t = 8.3\text{ ms}$ (60 Hz), sine	4800 A 5280 A
	$T_{VJ} = 150^\circ\text{C}$; $t = 10\text{ ms}$ (50 Hz), sine $t = 8.3\text{ ms}$ (60 Hz), sine	4320 A 4750 A
I^2t	$T_{VJ} = 45^\circ\text{C}$; $t = 10\text{ ms}$ (50 Hz), sine $t = 8.3\text{ ms}$ (60 Hz), sine	115200 A ² s 117100 A ² s
	$T_{VJ} = 150^\circ\text{C}$; $t = 10\text{ ms}$ (50 Hz), sine $t = 8.3\text{ ms}$ (60 Hz), sine	93300 A ² s 94800 A ² s
T_{VJ}		-40...+150 °C
T_{stg}		-40...+125 °C
T_{Smax}		110 °C
P_{tot}	$T_C = 25^\circ\text{C}$	1750 W
V_{ISOL}	50/60 Hz, RMS $t = 1\text{ min}$	3000 V~
	$I_{ISOL} \leq 1\text{ mA}$ $t = 1\text{ s}$	3600 V~
M_d	Mounting torque (M6)	2.25-2.75/20-25 Nm/lb.in.
	Terminal connection torque (M6)	4.50-5.50/40-48 Nm/lb.in.
d_s	Creeping distance on surface	12.7 mm
d_A	Strike distance through air	9.6 mm
a	Maximum allowable acceleration	50 m/s ²
Weight		150 g

Features

- International standard package with DCB ceramic base plate
- Planar passivated chips
- Short recovery time
- Low switching losses
- Soft recovery behaviour
- Isolation voltage 3600 V~
- UL registered E 72873

Applications

- Antiparallel diode for high frequency switching devices
- Free wheeling diode in converters and motor control circuits
- Inductive heating and melting
- Uninterruptible power supplies (UPS)
- Ultrasonic cleaners and welders

Advantages

- High reliability circuit operation
- Low voltage peaks for reduced protection circuits
- Low noise switching
- Low losses

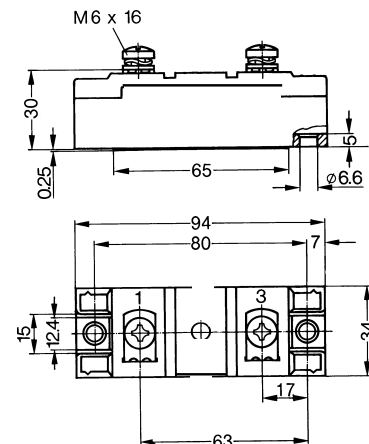
Symbol	Test Conditions	Characteristic Values (per diode)		
		typ.	max.	
I_R	$T_{VJ} = 25^\circ\text{C}$ $V_R = V_{RRM}$		24 mA	
	$T_{VJ} = 25^\circ\text{C}$ $V_R = 0.8 \cdot V_{RRM}$		6 mA	
	$T_{VJ} = 125^\circ\text{C}$ $V_R = 0.8 \cdot V_{RRM}$		120 mA	
V_F	$I_F = 300\text{ A}$; $T_{VJ} = 125^\circ\text{C}$		1.51 V	
	$T_{VJ} = 25^\circ\text{C}$		1.78 V	
	$I_F = 520\text{ A}$; $T_{VJ} = 125^\circ\text{C}$		1.76 V	
	$T_{VJ} = 25^\circ\text{C}$		1.96 V	
V_{TO}	For power-loss calculations only		1.16 V	
r_T			1.15 mΩ	
R_{thJH}	DC current		0.114 K/W	
R_{thJC}	DC current		0.071 K/W	
t_{rr}	$I_F = 600\text{ A}$ $V_R = 600\text{ V}$ $-di/dt = 800\text{ A}/\mu\text{s}$	450	$T_{VJ} = 100^\circ\text{C}$	500 ns
			$T_{VJ} = 25^\circ\text{C}$	110 A
			$T_{VJ} = 100^\circ\text{C}$	165 A

① I_{FAVM} rating includes reverse blocking losses at T_{VJM} , $V_R = 0.6 V_{RRM}$, duty cycle $d = 0.5$

Data according to IEC 60747

IXYS reserves the right to change limits, test conditions and dimensions

Dimensions in mm (1 mm = 0.0394")



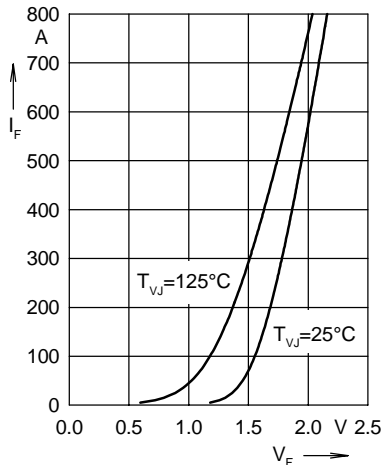


Fig. 1 Forward current I_F versus V_F

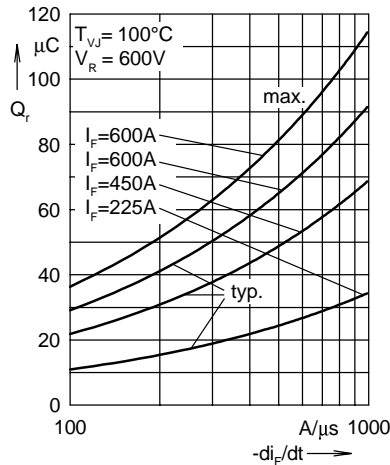


Fig. 2 Reverse recovery charge Q_r versus $-di_F/dt$

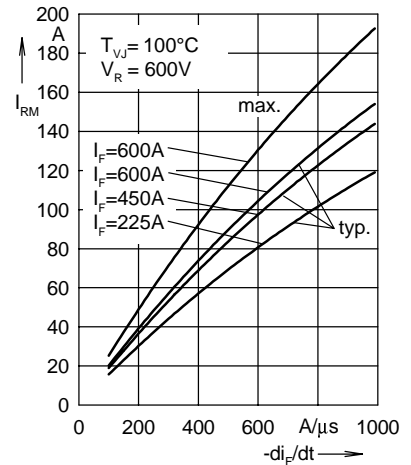


Fig. 3 Peak reverse current I_{RM} versus $-di_F/dt$

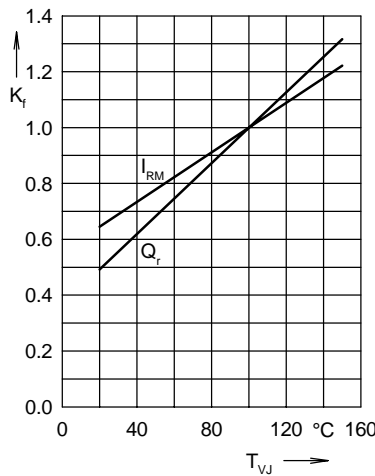


Fig. 4 Dynamic parameters Q_r, I_{RM} versus T_{VJ}

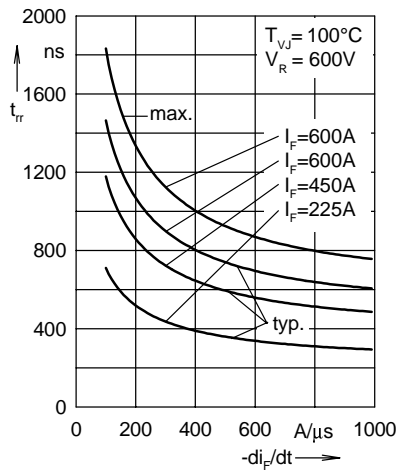


Fig. 5 Recovery time t_{rr} versus $-di_F/dt$

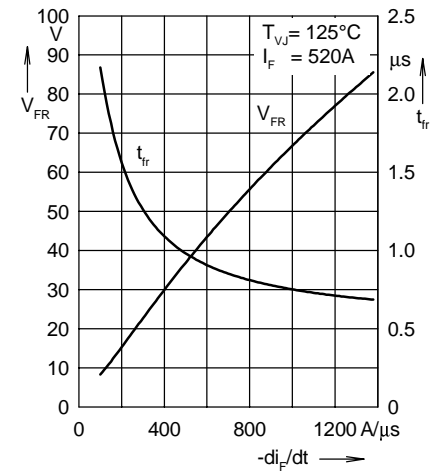


Fig. 6 Peak forward voltage V_{FR} and t_{tr} versus di_F/dt

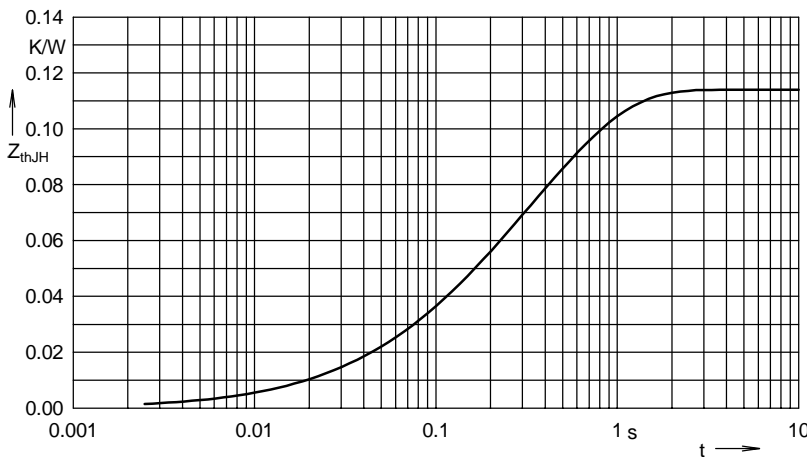


Fig. 7 Transient thermal impedance junction to case

Constants for Z_{thJS} calculation:

i	R_{thi} (K/W)	t_i (s)
1	0.001	0.08
2	0.004	0.024
3	0.027	0.112
4	0.082	0.464